

Electrical Characteristics (T_J=25°C unless otherwise noted)

| Symbol | Parameter | Conditions | Min | Тур | Max | Units |
|-----------------------|------------------------------------|--|------|------|------|-------|
| STATIC F | PARAMETERS | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $I_{D} = -250 \mu A, V_{GS} = 0 V$ | -40 | | | V |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = -40V, V_{GS} = 0V$ | | | -1 | |
| | | $T_J = 55^{\circ}C$ | 0 | | -5 | μA |
| I _{GSS} | Gate-Body leakage current | $V_{DS} = 0V, V_{GS} = \pm 20V$ | | | ±100 | nA |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS} I_D = -250 \mu A$ | -1.7 | -1.9 | -2.5 | V |
| I _{D(ON)} | On state drain current | $V_{GS} = -10V, V_{DS} = -5V$ | -120 | | | А |
| | | $V_{GS} = -10V, I_{D} = -10A$ | | 12.5 | 15 | |
| R _{DS(ON)} | Static Drain-Source On-Resistance | T _J =125°0 | C | 19 | 23 | mΩ |
| | | $V_{GS} = -4.5V, I_{D} = -8A$ | | 16 | 20 | |
| g fs | Forward Transconductance | $V_{DS} = -5V, I_{D} = -10A$ | | 25 | | S |
| V _{SD} | Diode Forward Voltage | $I_{S} = -1A, V_{GS} = 0V$ | | -0.7 | -1 | V |
| I _S | Maximum Body-Diode Continuous Cur | rent | | | -3 | Α |
| DYNAMIC | PARAMETERS | | | | | - |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =-20V, f=1MHz | | 2500 | 3000 | pF |
| C _{oss} | Output Capacitance | | | 260 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 180 | | pF |
| R _g | Gate resistance | V _{GS} =0V, V _{DS} =0V, f=1MHz | 2.5 | 4 | 6 | Ω |
| SWITCHI | NG PARAMETERS | | | | | - |
| Q _g (10V) | Total Gate Charge | V _{GS} =-10V, V _{DS} =-20V, I _D =-10A | | 42 | 55 | nC |
| Q _g (4.5V) | Total Gate Charge | | | 18.6 | | nC |
| Q _{gs} | Gate Source Charge | | | 7 | | nC |
| Q _{gd} | Gate Drain Charge | | | 8.6 | | nC |
| t _{D(on)} | Turn-On DelayTime | | | 9.4 | | ns |
| t _r | Turn-On Rise Time | V _{GS} =-10V, V _{DS} =-20V, | | 20 | | ns |
| t _{D(off)} | Turn-Off DelayTime | $R_L = 2\Omega, R_{GEN} = 3\Omega$ | | 55 | | ns |
| t _f | Turn-Off Fall Time | 7 | | 30 | | ns |
| t _{rr} | Body Diode Reverse Recovery Time | I _F =-10A, dI/dt=100A/μs | | 38 | 49 | ns |
| Q _{rr} | Body Diode Reverse Recovery Charge | ₂ I _F =-10A, dI/dt=100A/μs | | 47 | | nC |

A: The value of R $_{0.JA}$ is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A = 25°C. The value in any given application depends on the user's specific board design.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R $_{\rm 0JA}$ is the sum of the thermal impedence from junction to lead R $_{\rm 0JL}$ and lead to ambient.

D. The static characteristics in Figures 1 to 6 are obtained using t \leqslant 300 μs pulses, duty cycle 0.5% max.

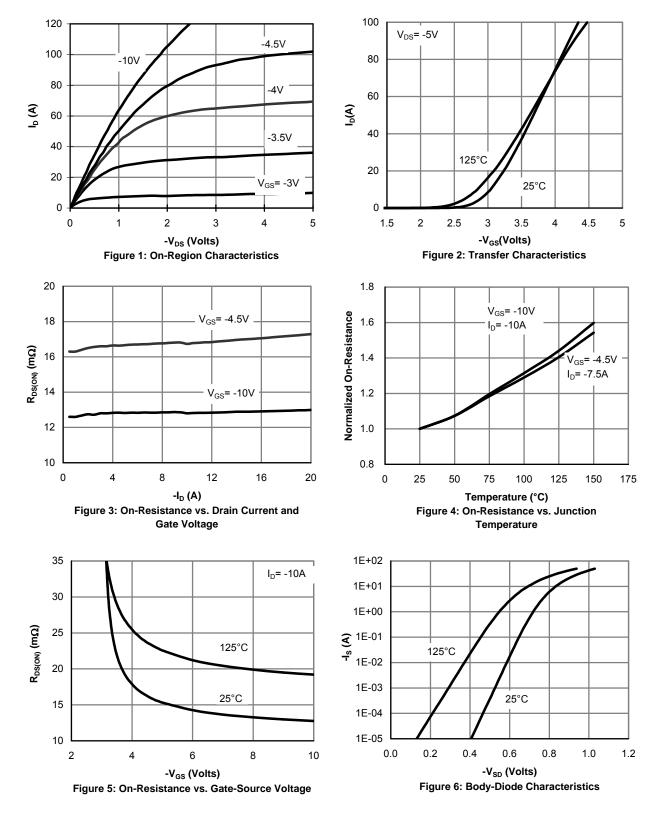
E. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with $T_A=25$ °C. The SOA curve provides a single pulse rating.

F. The current rating is based on the t \leqslant 10s thermal resistance rating.

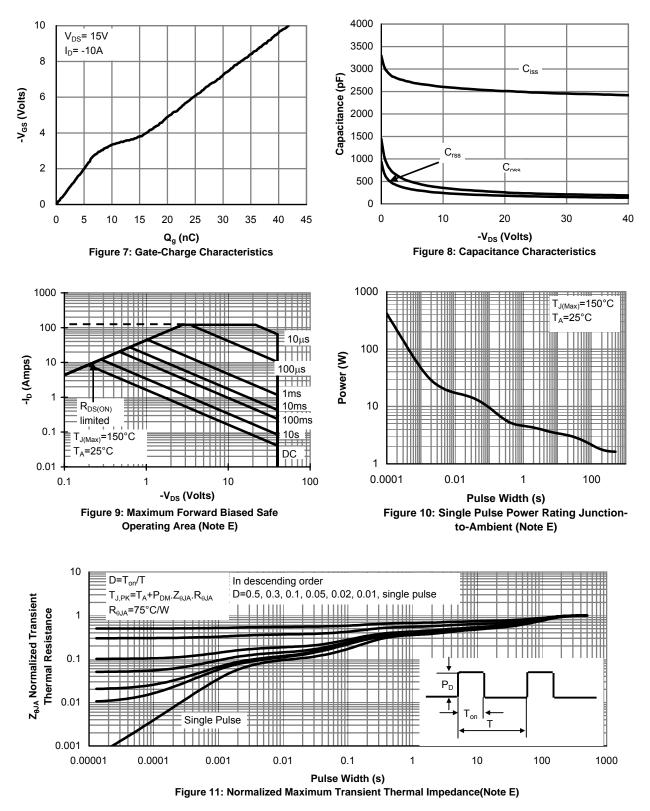
G. E_{AR} and I_{AR} ratings are based on low frequency and duty cycles to keep T_j =25C.

Rev0 April 2008

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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



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